


<b>Search Notes</b> 	<b>Application/Control No.</b> 10563429	<b>Applicant(s)/Patent Under Reexamination</b> INOUE, FUJIO
	<b>Examiner</b> Chen-Wen Jiang	<b>Art Unit</b> 3744

SEARCHED			
Class	Subclass	Date	Examiner
236	93A,93R,101C		
123	41.08		
137	468	5/26/09	CJ

SEARCH NOTES			
Search Notes		Date	Examiner
EAST Searched			
Inventor Searched		5/26/09	CJ

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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